BLS6G2933S-130

LDMOS S-band radar power transistor

Rev. 01 — 11 December 2008 Objective data sheet

1. Product profile

1.1 General description

130 W LDMOS power transistor intended for radar applications in the 2.9 GHz to 3.3 GHz range.

Table 1. Typical performance

Typical RF performance at T_{case} = 25 °C; t_p = 300 µs; δ = 10 %; I_{Dq} = 100 mA; in a class-AB production test circuit.

Mode of operation	f	V_{DS}	P_L	G_p	η_D	t_r	t_f
	(GHz)	(V)	(W)	(dB)	(%)	(ns)	(ns)
pulsed RF	2.9 to 3.3	32	130	12.5	47	20	6

CAUTION

This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features

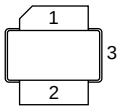
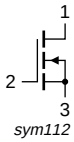
- Typical pulsed RF performance at a frequency of 2.9 GHz to 3.3 GHz, a supply voltage of 32 V, an I_{Dq} of 100 mA, a t_p of 300 µs with δ of 10 %:
  - Output power = 130 W
  - Power gain = 12.5 dB
  - Efficiency = 47 %
- Easy power control
- Integrated ESD protection
- High flexibility with respect to pulse formats
- Excellent ruggedness
- High efficiency
- Excellent thermal stability
- Designed for broadband operation (2.9 GHz to 3.3 GHz)
- Internally matched for ease of use
- Compliant to Directive 2002/95/EC, regarding restriction of hazardous substances (RoHS)

1.3 Applications

- S-band power amplifiers for radar applications in the 2.9 GHz to 3.3 GHz frequency range

2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	drain		
2	gate		
3	source [1]		

sym112

[1] Connected to flange.

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BLS6G2933S-130	-	ceramic earless flanged cavity package; 2 leads	SOT922-1

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Min	Max	Unit
V_{DS}	drain-source voltage	-	60	V
V_{GS}	gate-source voltage	–0.5	+13	V
I_D	drain current	-	33	A
T_{stg}	storage temperature	–65	+150	°C
T_j	junction temperature	-	225	°C

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
$Z_{th(j-mb)}$	transient thermal impedance from junction to mounting base	T_{case} = 85 °C; P_L = 130 W		
		t_p = 100 µs; δ = 10 %	0.23	K/W
		t_p = 200 µs; δ = 10 %	0.28	K/W
		t_p = 300 µs; δ = 10 %	0.32	K/W
		t_p = 100 µs; δ = 20 %	0.33	K/W

6. Characteristics

Table 6. Characteristics

T_j = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$V_{(BR)DSS}$	drain-source breakdown voltage	V_{GS} = 0 V; I_D = 0.6 mA	60	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	V_{DS} = 10 V; I_D = 180 mA	1.4	1.8	2.4	V
I_{DSS}	drain leakage current	V_{GS} = 0 V; V_{DS} = 28 V	-	-	4.2	µA
I_{DSX}	drain cut-off current	V_{GS} = $V_{GS(th)}$ + 3.75 V; V_{DS} = 10 V	27	33	-	A
I_{GSS}	gate leakage current	V_{GS} = 11 V; V_{DS} = 0 V	-	-	450	nA
g_{fs}	forward transconductance	V_{DS} = 10 V; I_D = 9 A	8.1	13	-	S
$R_{DS(on)}$	drain-source on-state resistance	V_{GS} = $V_{GS(th)}$ + 3.75 V; I_D = 6.3 A	-	0.085	0.135	Ω

7. Application information

Table 7. Application information

Mode of operation: pulsed RF; t_p = 300 µs; δ = 10 %; RF performance at V_{DS} = 32 V; I_{Dq} = 100 mA; T_{case} = 25 °C; unless otherwise specified, in a class-AB production circuit.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
P_L	output power		-	130	-	W
V_{CC}	supply voltage	P_L = 130 W	-	-	32	V
G_p	power gain	P_L = 130 W	10	12.5	-	dB
RL_{in}	input return loss	P_L = 130 W	-	10	-	dB
$P_{L(1dB)}$	output power at 1 dB gain compression		-	140	-	W
η_D	drain efficiency	P_L = 130 W	40	47	-	%
$P_{droop(pulse)}$	pulse droop power	P_L = 130 W	-	0	0.5	dB
t_r	rise time	P_L = 130 W	-	20	50	ns
t_f	fall time	P_L = 130 W	-	6	50	ns

Table 8. Typical impedance

f	Z_S	Z_L
GHz	Ω	Ω
2.9	2.2 – j7.6	4.5 – j5.6
3.0	2.5 – j6.6	4.3 – j5.7
3.1	3.2 – j5.6	4.0 – j5.8
3.2	4.5 – j4.8	3.6 – j5.8
3.3	6.8 – j5.3	3.2 – j5.8

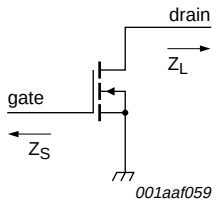
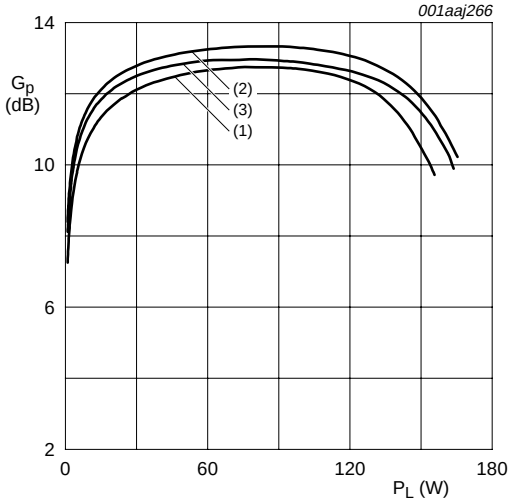


Fig 1. Definition of transistor impedance

7.1 Ruggedness in class-AB operation

The BLS6G2933S-130 is capable of withstanding a load mismatch corresponding to VSWR = 5 : 1 through all phases under the following conditions: V_{DS} = 32 V; I_{Dq} = 100 mA; P_L = 130 W; t_p = 300 µs; δ = 10 %.

7.2 Graphs



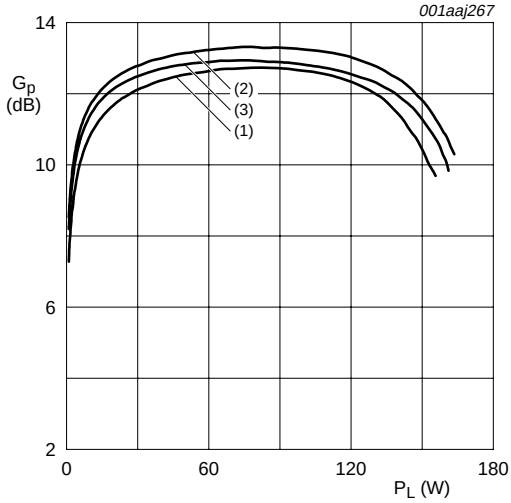
V_{DS} = 32 V; I_{Dq} = 100 mA; t_p = 300 µs; δ = 10 %.

(1) f = 2.9 GHz

(2) f = 3.1 GHz

(3) f = 3.3 GHz

Fig 2. Power gain as a function of load power; typical values



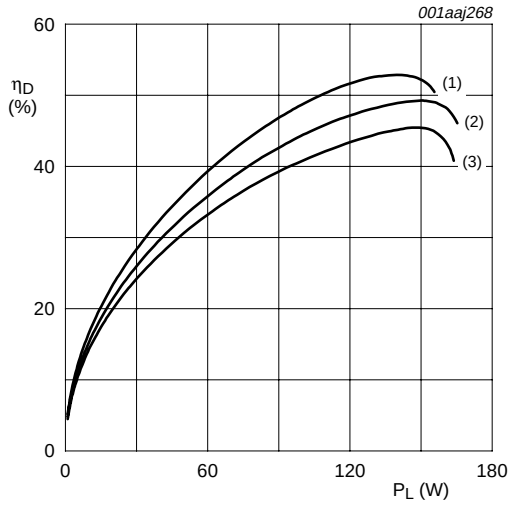
V_{DS} = 32 V; I_{Dq} = 100 mA; t_p = 100 µs; δ = 20 %.

(1) f = 2.9 GHz

(2) f = 3.1 GHz

(3) f = 3.3 GHz

Fig 3. Power gain as a function of load power; typical values



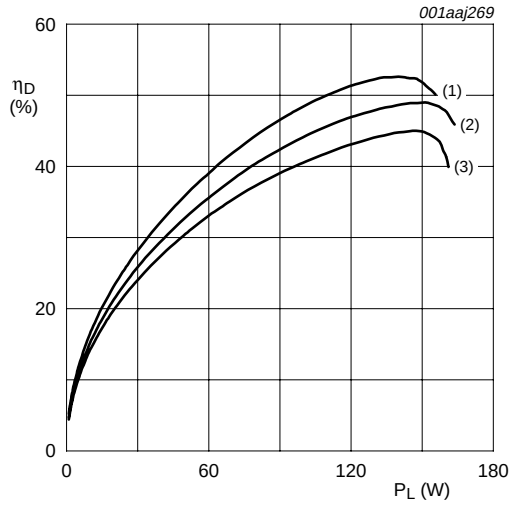
V_{DS} = 32 V; I_{Dq} = 100 mA; t_p = 300 µs; δ = 10 %.

(1) f = 2.9 GHz

(2) f = 3.1 GHz

(3) f = 3.3 GHz

Fig 4. Drain efficiency as a function of load power; typical values



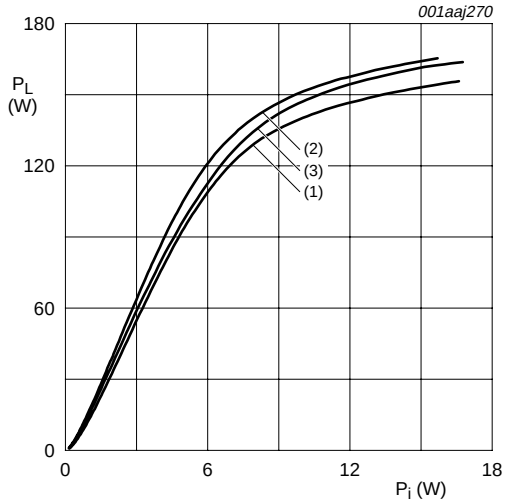
V_{DS} = 32 V; I_{Dq} = 100 mA; t_p = 100 µs; δ = 20 %.

(1) f = 2.9 GHz

(2) f = 3.1 GHz

(3) f = 3.3 GHz

Fig 5. Drain efficiency as a function of load power; typical values



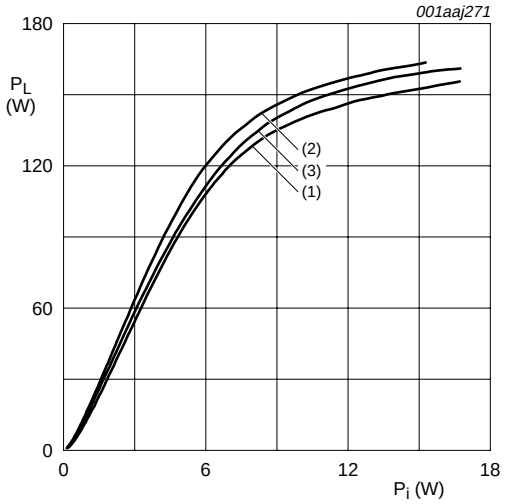
V_{DS} = 32 V; I_{Dq} = 100 mA; t_p = 300 µs; δ = 10 %.

(1) f = 2.9 GHz

(2) f = 3.1 GHz

(3) f = 3.3 GHz

Fig 6. Load power as a function of input power; typical values



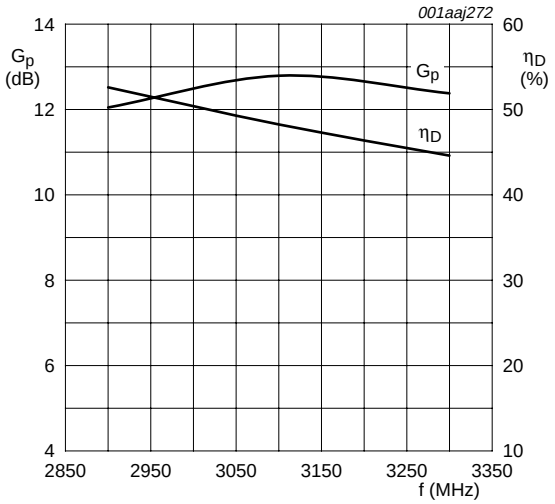
V_{DS} = 32 V; I_{Dq} = 100 mA; t_p = 100 µs; δ = 20 %.

(1) f = 2.9 GHz

(2) f = 3.1 GHz

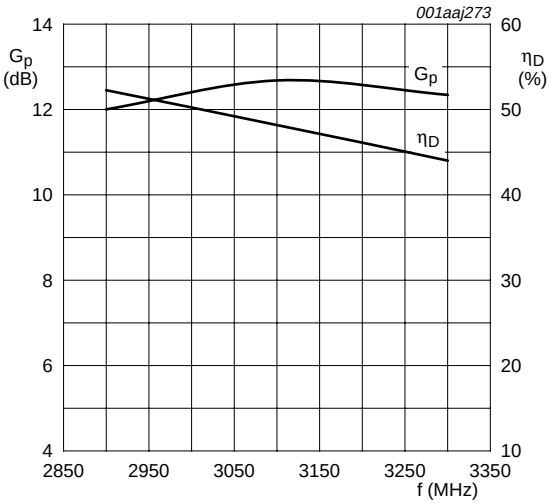
(3) f = 3.3 GHz

Fig 7. Load power as a function of input power; typical values



P_L = 130 W; V_{DS} = 32 V; I_{Dq} = 100 mA; t_p = 300 µs; δ = 10 %.

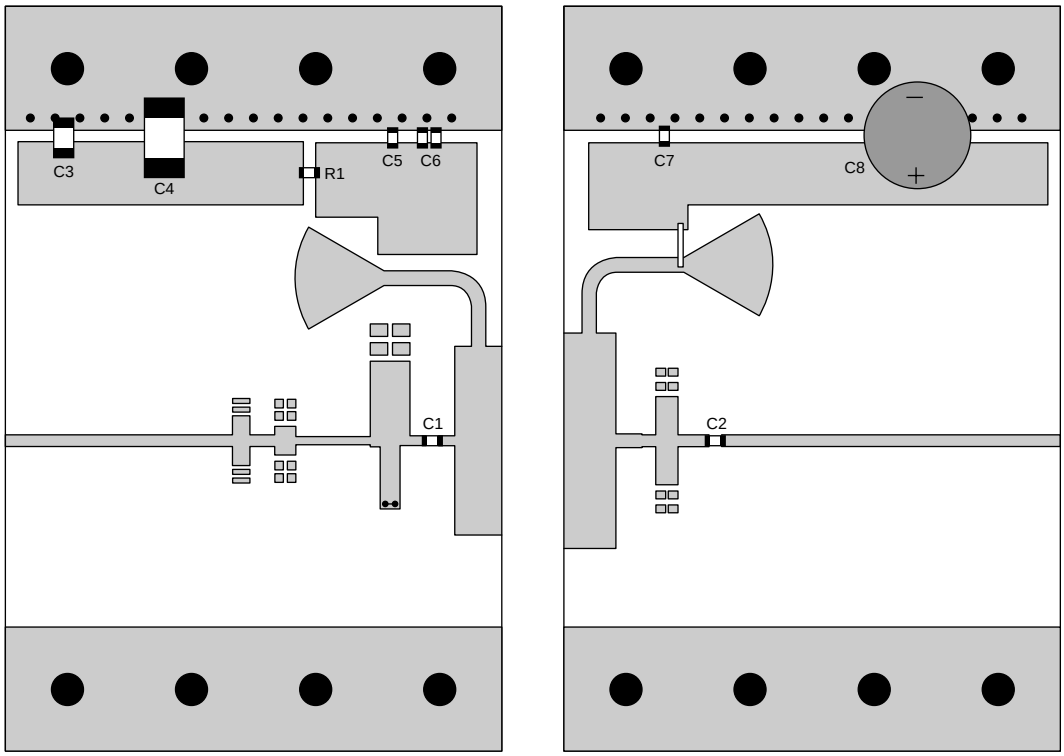
Fig 8. Power gain and drain efficiency as function of frequency; typical values



P_L = 130 W; V_{DS} = 32 V; I_{Dq} = 100 mA; t_p = 100 µs; δ = 20 %.

Fig 9. Power gain and drain efficiency as function of frequency; typical values

8. Test information



Striplines are on a double copper-clad Duroid 6006 Printed-Circuit Board (PCB) with ε_r = 6.15 and thickness = 0.64 mm.

See Table 9 for list of components.

Fig 10. Component layout for 2700 MHz to 3100 MHz test circuit

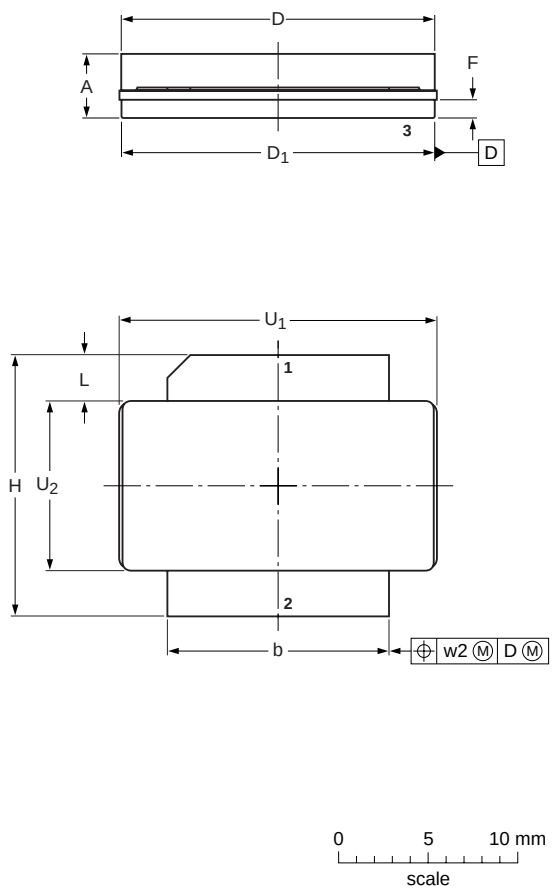
Table 9. List of components

See Figure 10.

Component	Description	Value	Quantity	Remarks
C1, C2, C5, C7	multilayer ceramic chip capacitor	33 pF	1	ATC 100A or equivalent
C3	multilayer ceramic chip capacitor	1 µF	1	ATC 900A or equivalent
C4	multilayer ceramic chip capacitor	47 µF; 63 V	1	
C6	multilayer ceramic chip capacitor	1 nF	2	ATC 700A or equivalent
C8	electrolytic capacitor	68 µF; 63 V	1	
R1	SMD resistor	47 Ω	1	SMD 0603

9. Package outline

Ceramic earless flanged cavity package; 2 leads **SOT922-1**



DIMENSIONS (mm are the original dimensions)

UNIT	A	b	c	D	D_1	E	E_1	F	H	L	Q	U_1	U_2	w_2
mm	4.22 3.53	12.42 12.17	0.15 0.10	17.58 17.22	17.50 17.25	9.53 9.27	9.27 9.02	1.32 0.81	15.62 14.34	3.05 2.03	1.70 1.45	17.75 17.50	9.53 9.27	0.25
inches	0.166 0.139	0.489 0.479	0.006 0.004	0.692 0.678	0.689 0.679	0.375 0.365	0.365 0.355	0.052 0.032	0.615 0.525	0.12 0.08	0.067 0.057	0.699 0.689	0.375 0.365	0.010

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT922-1						~~05-11-14~~ 05-11-22

Fig 11. Package outline SOT922-1

10. Abbreviations

Table 10. Abbreviations

Acronym	Description
LDMOS	Laterally Diffused Metal-Oxide Semiconductor
LDMOST	Laterally Diffused Metal-Oxide Semiconductor Transistor
RF	Radio Frequency
S-band	Short wave Band
SMD	Surface Mounted Device
VSWR	Voltage Standing-Wave Ratio

11. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BLS6G2933S-130_1	20081211	Objective data sheet	-	-

12. Legal information

12.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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14. Contents

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